ATTY DOCKET NO. SERIAL NO. **MIT-114J** 09/898,815 INFORMATION DISCLOSURE Shi-Chang Wooh (Use several sheets if necessary) Applicant(s) MAY 1 8 2004 FILING GROUP Date July 5, 2001 2878 **U.S. PATENT DOCUMENTS** \*EXAMINER FILING DATE DOCUMENT NUMBER DATE NAME CLASS SUBCLASS INITIAL IF APPROPRIATE 07/03/2001 6,253,618 Wooh 6,092,420 07/25/2000 Kimura et al. 6,078,788 06/20/2000 Haardt 05/09/2000 6,061,553 Matsuoka et al. 5,930,293 07/27/1999 Light et al. 07/20/1999 5,926,503 Kelton et al. 10/27/1998 Wright et al. 5,827,188 10/20/1998 Schindel et al. 5,824,908 5,818,592 10/06/1998 Womack et al. 09/29/1998 Nogami 5,814,732 09/29/1998 Brodeur et al. 5,814,730 **FOREIGN PATENT DOCUMENTS** TRANSLATION DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS YES NO JP-4-64350 02/28/1992 Japan EP 0 935 258 A1 08/11/1999 Europe GB 2008756 A 06/06/1979 **United Kingdom** WO 96/22527 07/25/1996 **WIPO** 05/02/1996 WIPO WO 96/12951 OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Thompson et al., "Quantitative Nondestructive Evaluation", Center for NDE and Department of Aerospace Engineering and Engineering Mechanics, Iowa State University, American Institute of Physics, Melville, NY, AIP Conference Proceedings, Vol. 19A, pp. 831-838, July (1999). C.B. Scruby and L.E.Drain, "Laser Ultrasonics: Techniques and Applications", Adam Hilger, Briston UK (1990), Ch. 6, pp. 324-405.

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